

<b>Notice of References Cited</b>		Application/Control No. 10/582,241	Applicant(s)/Patent Under Reexamination PARK ET AL.	
		Examiner QUANG NGUYEN, Ph.D.	Art Unit 1633	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0197605	12-2002	Nakagawa et al.	435/6
	B	US-			
	C	US-			
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